


<b>Search Notes</b>  	<b>Application/Control No.</b>  10715411	<b>Applicant(s)/Patent Under Reexamination</b>  WENG ET AL.
	<b>Examiner</b>  CHRIS PARRY	<b>Art Unit</b>  2421

SEARCHED			
Class	Subclass	Date	Examiner
725	80,82	12/16/2008	CLP

SEARCH NOTES		
Search Notes	Date	Examiner
See attached search strategy from EAST (USPAT; US-PGPUB; USOCR; EPO; JPO; IBM_TDB; DERWENT)	12/17/2008	CLP
Inventor search via PALM and EAST	12/17/2008	CLP
Consulted Primary Examiner Jason Salce (re: search)	12/16/2008	CLP

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

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